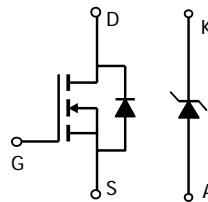
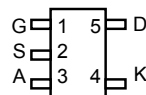


**AO3700**
**N-Channel Enhancement Mode Field Effect Transistor with Schottky Diode**
**General Description**

The AO3700 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. A Schottky diode is provided to facilitate the implementation of a bidirectional blocking switch, or for DC-DC conversion applications. Standard Product AO3700 is Pb-free (meets ROHS & Sony 259 specifications). AO3700L is a Green Product ordering option. AO3700 and AO3700L are electrically identical.

**Features**

$V_{DS} (V) = 30V$   
 $I_D = 3.3A (V_{GS} = 10V)$   
 $R_{DS(ON)} < 65m\Omega (V_{GS} = 10V)$   
 $R_{DS(ON)} < 75m\Omega (V_{GS} = 4.5V)$   
 $R_{DS(ON)} < 160m\Omega (V_{GS} = 2.5V)$   
**SCHOTTKY**  
 $V_{DS} (V) = 20V, I_F = 1A, V_F < 0.5V @ 0.5A$

 SOT-23-5  
 Top View

**Absolute Maximum Ratings  $T_A=25^\circ C$  unless otherwise noted**

| Parameter                               | Symbol         | MOSFET           | Schottky   | Units      |
|---|----------------|------------------|------------|------------|
| Drain-Source Voltage                    | $V_{DS}$       | 30               |            | V          |
| Gate-Source Voltage                     | $V_{GS}$       | $\pm 12$         |            | V          |
| Continuous Drain Current <sup>A</sup>   | $I_D$          | $T_A=25^\circ C$ | 3.3        | A          |
|   |                | $T_A=70^\circ C$ | 2.6        |            |
| Pulsed Drain Current <sup>B</sup>       | $I_{DM}$       | 10               |            |            |
| Schottky reverse voltage                | $V_{KA}$       |                  | 20         | V          |
| Continuous Forward Current <sup>A</sup> | $I_F$          | $T_A=25^\circ C$ | 2          | A          |
|   |                | $T_A=70^\circ C$ | 1          |            |
| Pulsed Forward Current <sup>B</sup>     | $I_{FM}$       |                  | 10         |            |
| Power Dissipation                       | $P_D$          | $T_A=25^\circ C$ | 1.15       | W          |
|   |                | $T_A=70^\circ C$ | 0.7        |            |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$ | -55 to 150       | -55 to 150 | $^\circ C$ |

| Parameter: Thermal Characteristics MOSFET |              | Symbol          | Typ   | Max | Units        |
|---|--------------|-----------------|-------|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup>  | $t \leq 10s$ | $R_{\theta JA}$ | 80.3  | 110 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup>  | Steady-State |                 | 117   | 150 |              |
| Maximum Junction-to-Lead <sup>C</sup>     | Steady-State | $R_{\theta JL}$ | 43    | 80  |              |
| Thermal Characteristics Schottky          |              |                 |       |     |              |
| Maximum Junction-to-Ambient <sup>A</sup>  | $t \leq 10s$ | $R_{\theta JA}$ | 109.4 | 135 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup>  | Steady-State |                 | 136.5 | 175 |              |
| Maximum Junction-to-Lead <sup>C</sup>     | Steady-State | $R_{\theta JL}$ | 58.5  | 80  |              |

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions   | Min | Typ      | Max      | Units            |
|-----------------------------|---------------------------------------|--|-----|----------|----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |          |          |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$  | 30  |          |          | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=24\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                 |     |          | 1<br>5   | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 12\text{V}$                                       |     |          | 100      | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$   | 1   | 1.4      | 2        | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=4.5\text{V}$ , $V_{DS}=5\text{V}$  | 10  |          |          | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=3.3\text{A}$<br>$T_J=125^\circ\text{C}$                 |     | 51<br>64 | 65<br>90 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=3.0\text{A}$   |     | 60       | 75       | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=2.5\text{V}$ , $I_D=1\text{A}$   |     | 100      | 160      | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=3.3\text{A}$   |     | 11.7     |          | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$   |     | 0.81     | 1        | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |          | 2.5      | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |          |          |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                         |     | 226      | 270      | pF               |
| $C_{oss}$                   | Output Capacitance                    |  |     | 39       |          | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |  |     | 29       |          | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          |     | 1.4      | 2.5      | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |          |          |                  |
| $Q_g$                       | Total Gate Charge                     | $V_{GS}=4.5\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=3.3\text{A}$                     |     | 4.6      | 5.5      | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |  |     | 1.4      |          | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |  |     | 0.55     |          | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=4.7\Omega$ ,<br>$R_{GEN}=6\Omega$ |     | 2.6      |          | ns               |
| $t_r$                       | Turn-On Rise Time                     |  |     | 3.2      |          | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |  |     | 14.5     |          | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 2.1      |          | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=3.3\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                |     | 10.2     | 13       | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=3.3\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                |     | 3.8      |          | nC               |
| <b>SCHOTTKY PARAMETERS</b>  |                                       |  |     |          |          |                  |
| $V_F$                       | Forward Voltage Drop                  | $I_F=0.5\text{A}$  |     | 0.39     | 0.5      | V                |
| $I_{rm}$                    | Maximum reverse leakage current       | $V_R=16\text{V}$   |     |          | 0.1      | mA               |
|                             |                                       | $V_R=16\text{V}$ , $T_J=125^\circ\text{C}$   |     |          | 20       |                  |
| $C_T$                       | Junction Capacitance                  | $V_R=10\text{V}$   |     | 34       |          | pF               |
| $t_{rr}$                    | Schottky Reverse Recovery Time        | $I_F=1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                  |     | 5.2      | 10       | ns               |
| $Q_{rr}$                    | Schottky Reverse Recovery Charge      | $I_F=1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                  |     | 0.8      |          | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using 80  $\mu\text{s}$  pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating. Rev0: October 2005

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

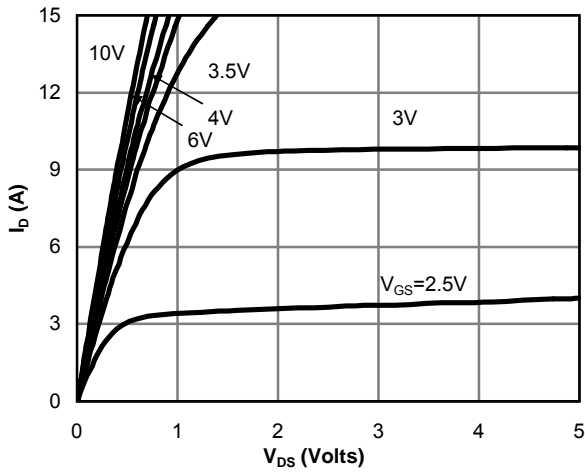


Fig 1: On-Region Characteristics

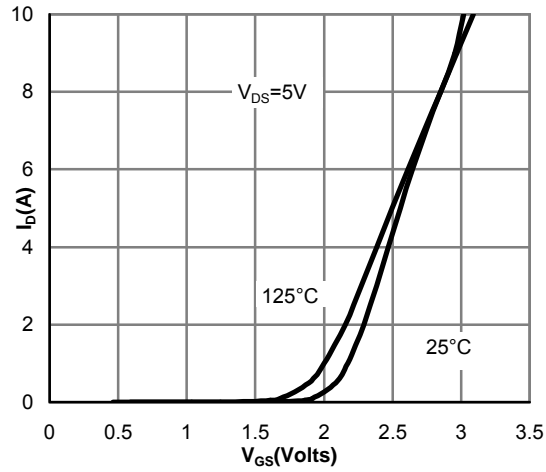


Figure 2: Transfer Characteristics

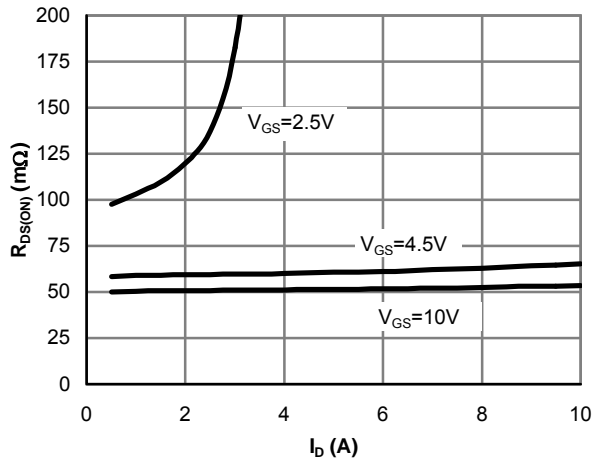


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

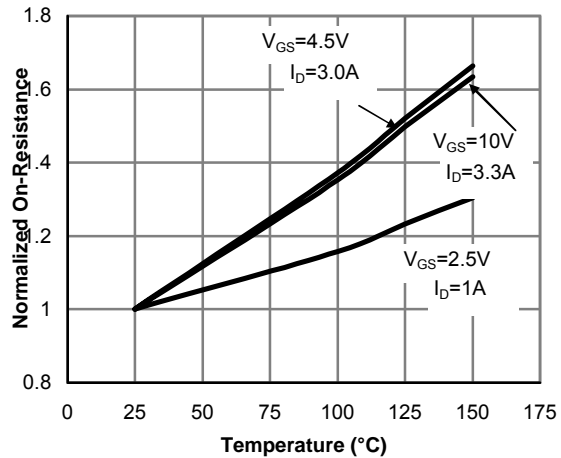


Figure 4: On-Resistance vs. Junction Temperature

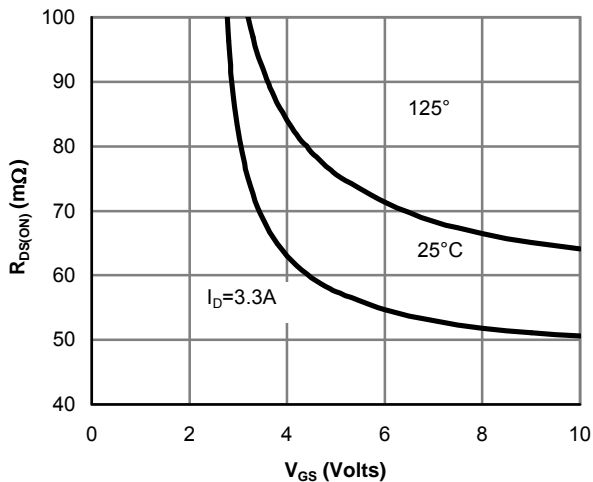


Figure 5: On-Resistance vs. Gate-Source Voltage

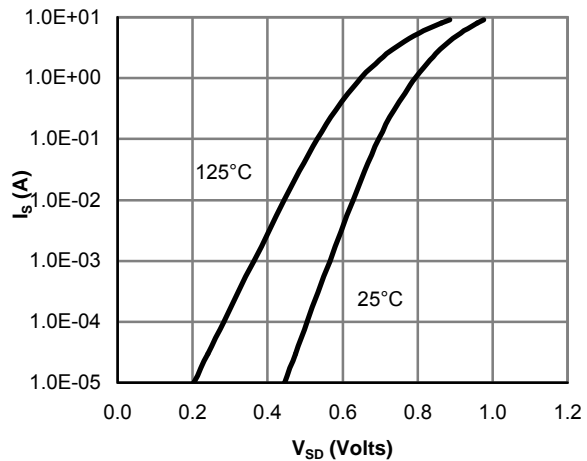


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

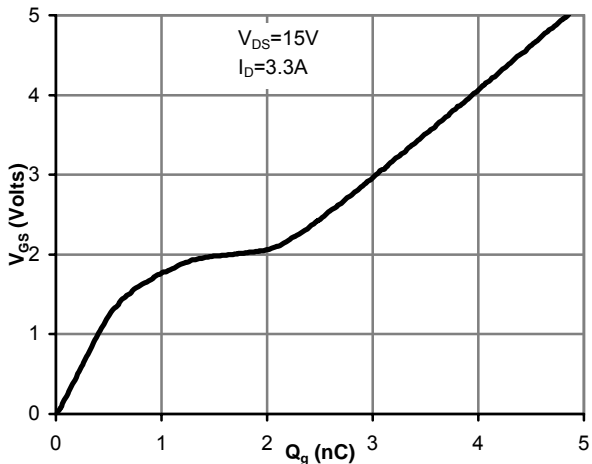


Figure 7: Gate-Charge Characteristics

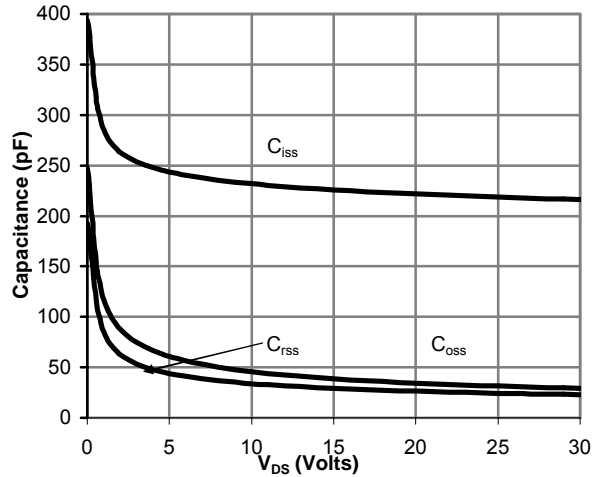


Figure 8: Capacitance Characteristics

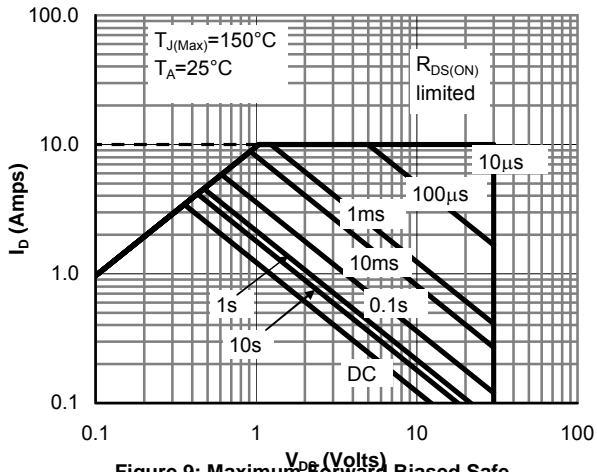


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

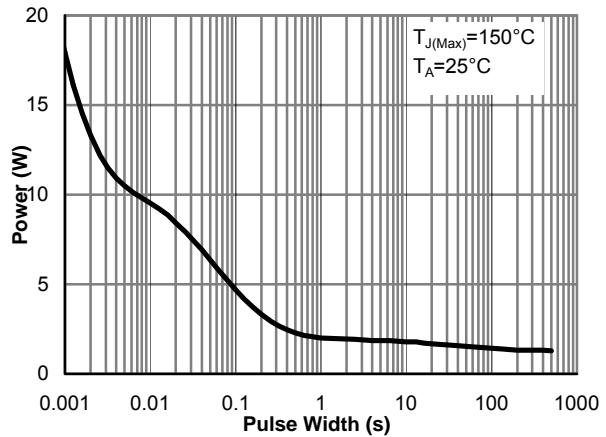


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

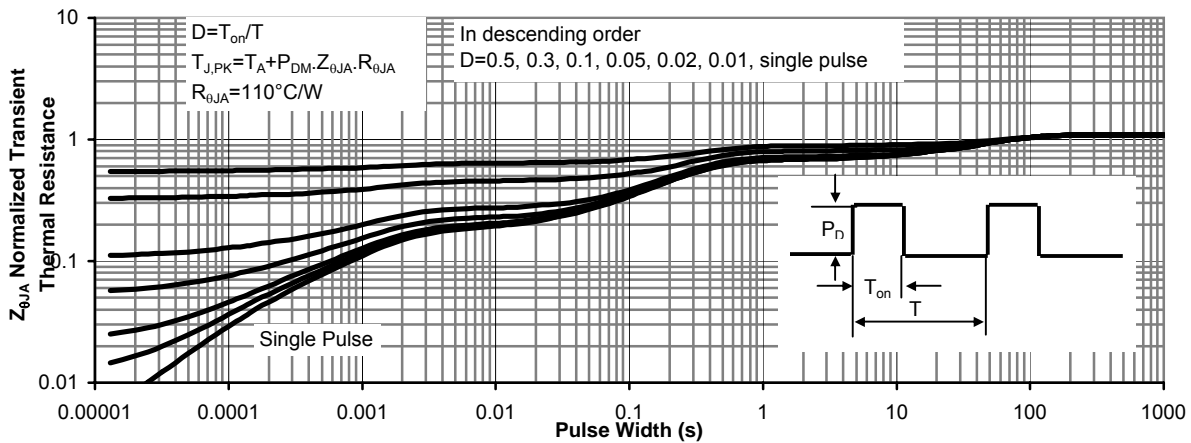


Figure 11: Normalized Maximum Transient Thermal Impedance

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: SCHOTTKY

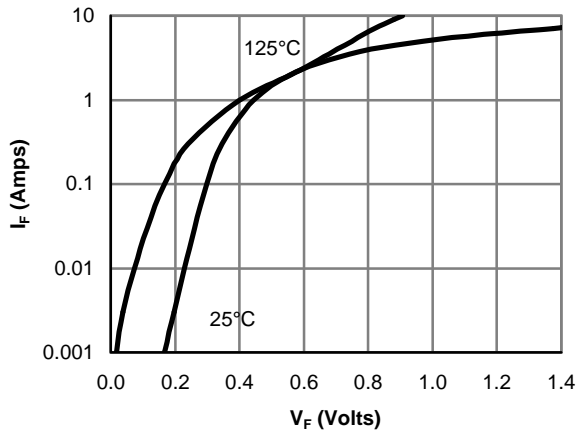


Figure 12: Schottky Forward Characteristics

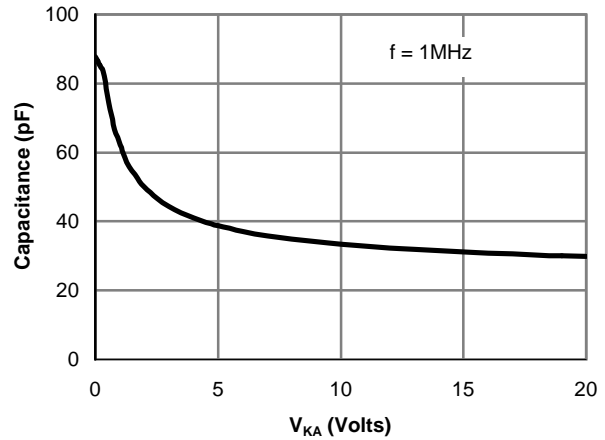


Figure 13: Schottky Capacitance Characteristics

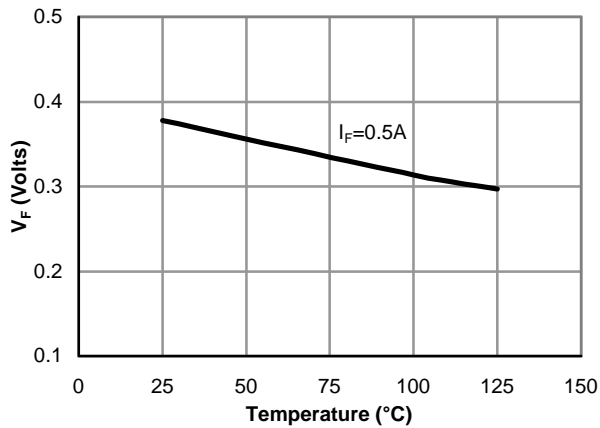


Figure 14: Schottky Forward Drop vs. Junction Temperature

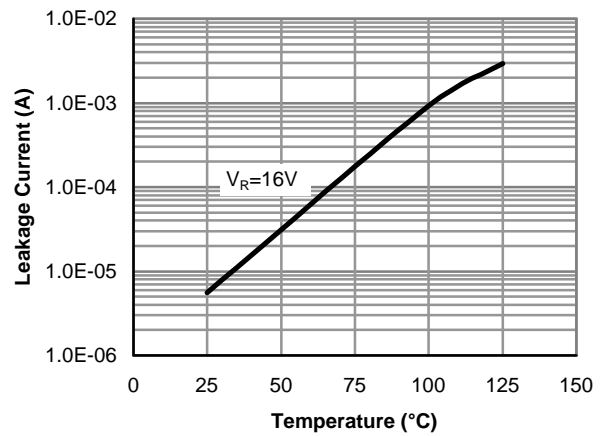


Figure 15: Schottky Leakage current vs. Junction Temperature

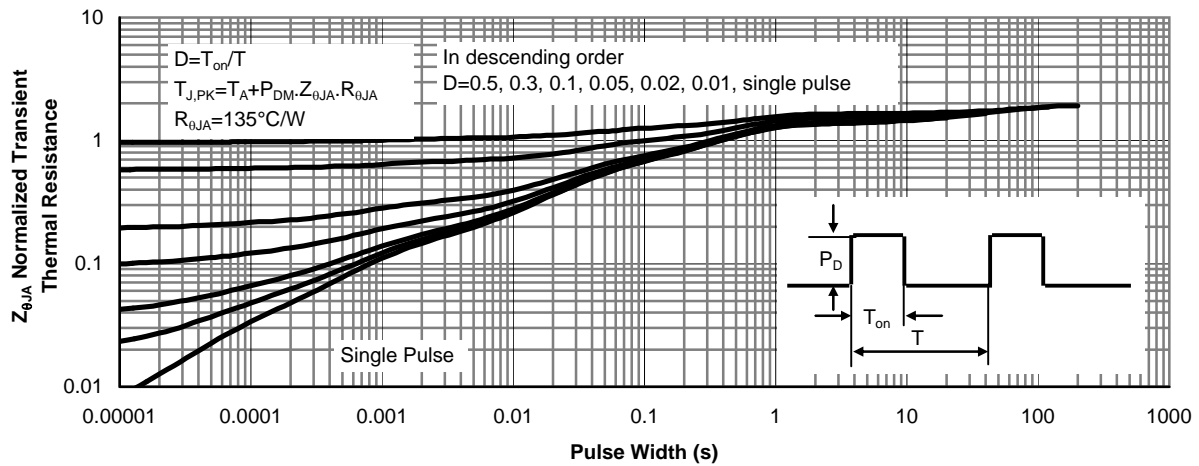


Figure 15: Schottky Normalized Maximum Transient Thermal Impedance